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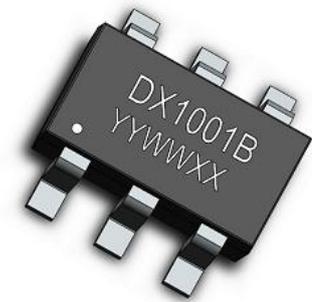


# DX1001 5V、4A Peak current low side Gan driver

氮竹科技

## 1. Features

- Separate output configuration to control rise and fall time respectively
- 5V driving voltage
- 1.4A/4A Peak source and sink current
- Low transmission delay (Typ. 6.3ns)
- Fast rise and fall time (Typ. 5.3ns and 3.3ns)
- Support positive and negative phase configuration
- Undervoltage unlock voltage 4V
- Operating temperature range: -40°C to 125°C



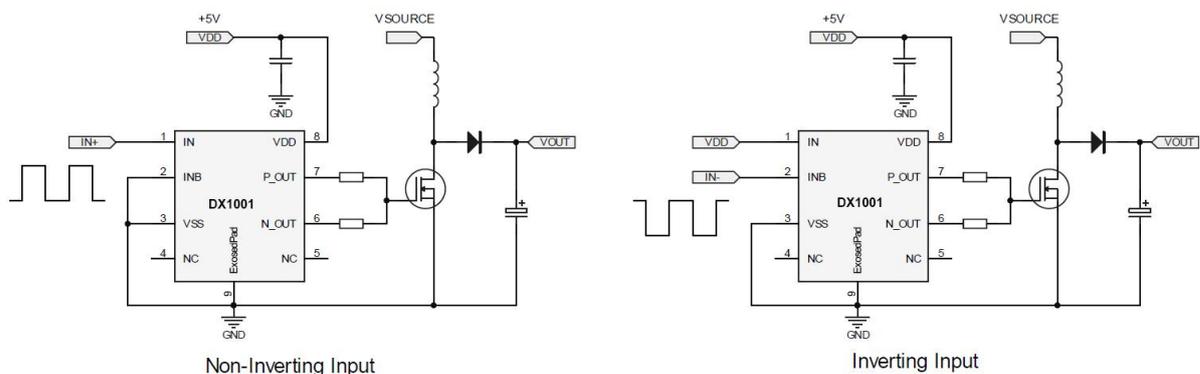
## 2. Applications

- Switching Power Supply
- AC/DC、DC/DC converter
- Synchronous rectification
- Envelope tracking

Part Number	Package	Packing
DX1001A	DFN3x3	Tape, 3K/reel
DX1001B	SOT23-6	Tape, 3K/reel

### Device Information

Typical Application Diagram

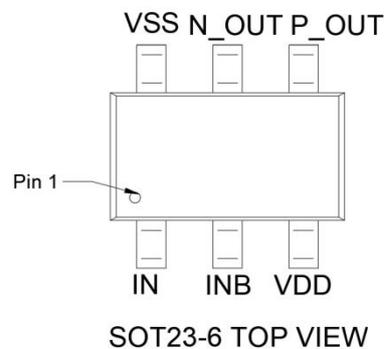
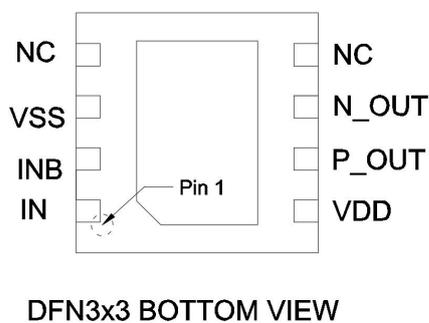




### 3. Description

DX1001 it is a single-channel high-speed driver with 5V output and a dedicated driver for enhanced GaN FET. DX1001 can provide asymmetric peak current driving capability of 1.4A source current and 4A sink current, which can optimize the turn-on and turn off time of the device respectively. The DX1001 provides inverting and noninverting inputs to satisfy requirements for inverting and Noninverting gate drive in a single device type. When the input pin is suspended, the internal output pull-up and pull-down resistors keep the output low. The DX1001 has undervoltage locking function, which can keep the output at low level before the VDD power supply voltage is in the working range.

### 4. Pin Configuration and Functions





Symbol	Describe	Application information
IN	Noninverting logic input	Connect VSS terminal when not in use.
INB	Inverting logic input	Connect VSS terminal when not in use.
VSS	Ground	All signals are referenced to this ground.
N_OUT	Sink current output	Connect to the Gate of GaN FET with a external driving resistor to control the turn-off speed.
P_OUT	Sourcing current output	Connect to the Gate of GaN FET with a external driving resistor to control the turn-on speed.
VDD	Driving voltage supply input	Bias power input.
EP	Heat sink	It is recommended to be grounded to facilitate heat dissipation.



## 5. Truth Table

IN	INB	P_OUT	N_OUT
L	L	OPEN	L
L	H	OPEN	L
H	L	H	OPEN
H	H	OPEN	L

## 6. Key Technical Indicators

### 6.1 Absolute Maximum Ratings

Over operating free-air temperature range(Unless otherwise noted) <sup>(1)</sup>

Description	Min	Max	Unit
VDD to VSS	-0.3	5.5	V
IN, INB to VSS	-0.3	20	V
N_OUT to VSS	-0.3	VDD+0.3	V
P_OUT to VSS	-0.3	VDD+0.3	V
Junction temperature		+150	°C
Storage temperature	-55	+150	°C

<sup>(1)</sup> Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



## 6.2 Recommended Operating conditions

Over operating free-air temperature range(Unless otherwise noted)

Description	Min	Max	Unit
VDD	4.2	5.2	V
IN, INB	4.0	18	V
Operating temperature	-20	+125	°C

## 6.3 Thermal Characteristics

Symbol	Description	Package	Value	Unit
$R_{\theta JA}$	Junction-to-ambient thermal resistance	DFN3x3	70	°C/W
		SOT23-6	170	°C/W
$R_{\theta JC(bottom)}$	Junction-to-board thermal resistance	DFN3x3	9.0	°C/W
		SOT23-6	120	°C/W



## 6.4 Electrical Characteristics

The maximum and minimum limits are determined by design, test, or data correlation. The typical values represent the most likely parametric norm at  $T_J = 25\text{ }^\circ\text{C}$  for reference purposes only. (unless otherwise specified,  $V_{DD} = 5\text{V}$ ).

Symbol	Description	Test conditions	Min.	Typ.	Max.	Unit
$V_{DD}$	VDD operating voltage	$T_J$ range of $-20^\circ\text{C}$ to $125^\circ\text{C}$	4.7	5.0	5.2	V
UVLO	VDD undervoltage lockout	VDD rising	3.8	4.0	4.2	V
	VDD undervoltage lockout hysteresis			0.1		V
	VDD undervoltage lockout to output delay time			1300		ns
$I_{LK-N}$	Output leakage current	$N\_OUT=V_{DD}$		0.5	15	$\mu\text{A}$
$I_{LK-P}$	Output leakage current	$P\_OUT=V_{DD}$		0.5	15	$\mu\text{A}$
<b>N Channel output</b>						
$R_{ON-N}$	Drive output resistance - pulling down	$V_{DD}=5\text{V}$			0.36	$\Omega$
<b>P Channel output</b>						
$R_{ON-P}$	Drive output resistance - pulling up	$V_{DD}=5\text{V}$		1.62	1.64	$\Omega$
<b>Logic input</b>						
$V_{IH}$	Input voltage - logic 1		2.05			V
$V_{IL}$	Input voltage - logic 0				1.78	V

## 6.5 High frequency characteristics

Over operating free-air temperature range (unless otherwise noted)

Symbol	Description	Test conditions	Min.	Typ.	Max.	Unit
$t_R$	Rise time <sup>1)</sup>	$C_L = 1000 \text{ pF}$		5.2		ns
$t_F$	Fall time	$C_L = 1000 \text{ pF}$		3.3		ns
$t_{D-ON}$	Turn-on propagation delay	$C_L = 1000 \text{ pF}$		6.3		ns
$t_{D-OFF}$	Turn-off propagation delay	$C_L = 1000 \text{ pF}$		6.3		ns

(1) The rise time is the time required for the output signal to rise from 10% to 90%.

(2) The fall time is the time required for the output signal to drop from 90% to 10%.

(3) The on propagation delay is the time required for the input signal to rise to 50% and the output signal to rise to 10%.

(4) The turn off propagation delay is the time required for the input signal to drop to 50% and the output signal to drop to 10%.

### 7. Characteristic curves

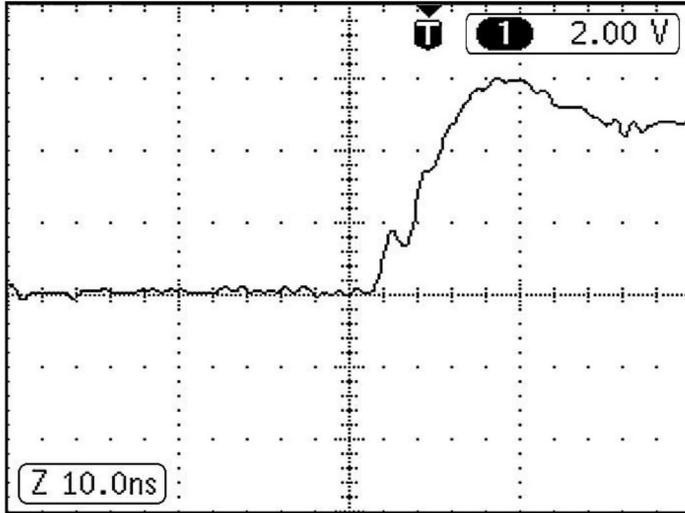


Figure 1. Rise time (VDD=5V, CL=1000pF)

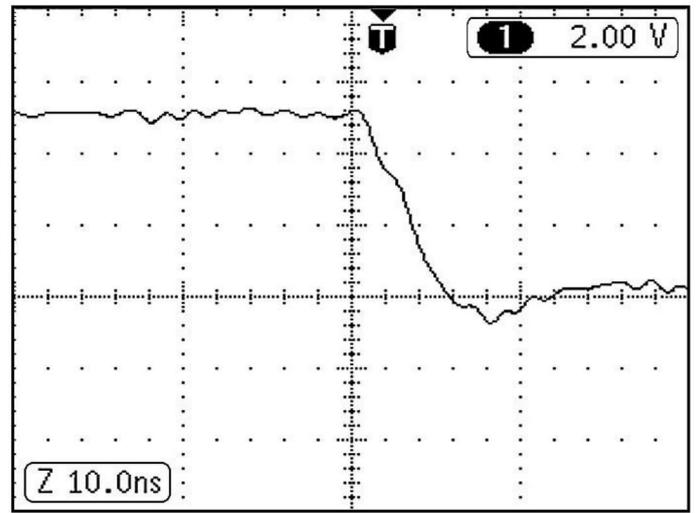


Figure 2. Fall time (VDD=5V, CL=1000pF)

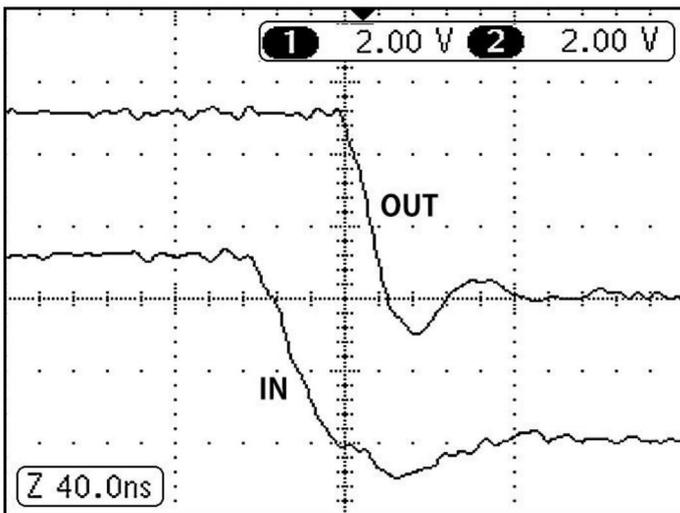
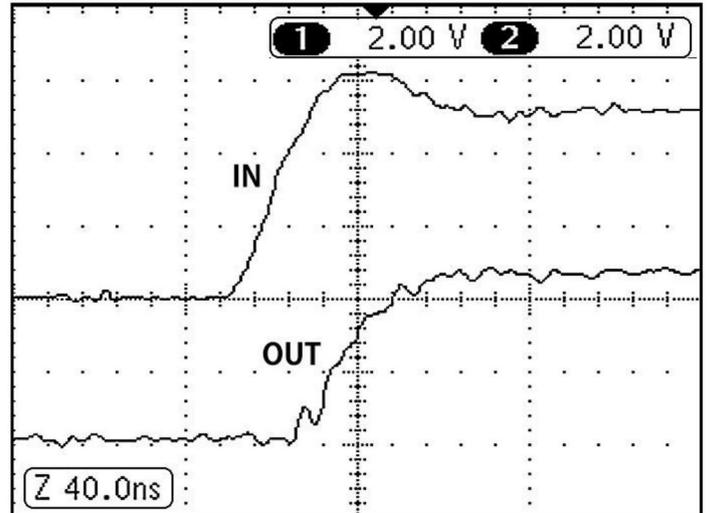


Figure3.Rise propagation delay (VDD=5V, CL=4700pF)



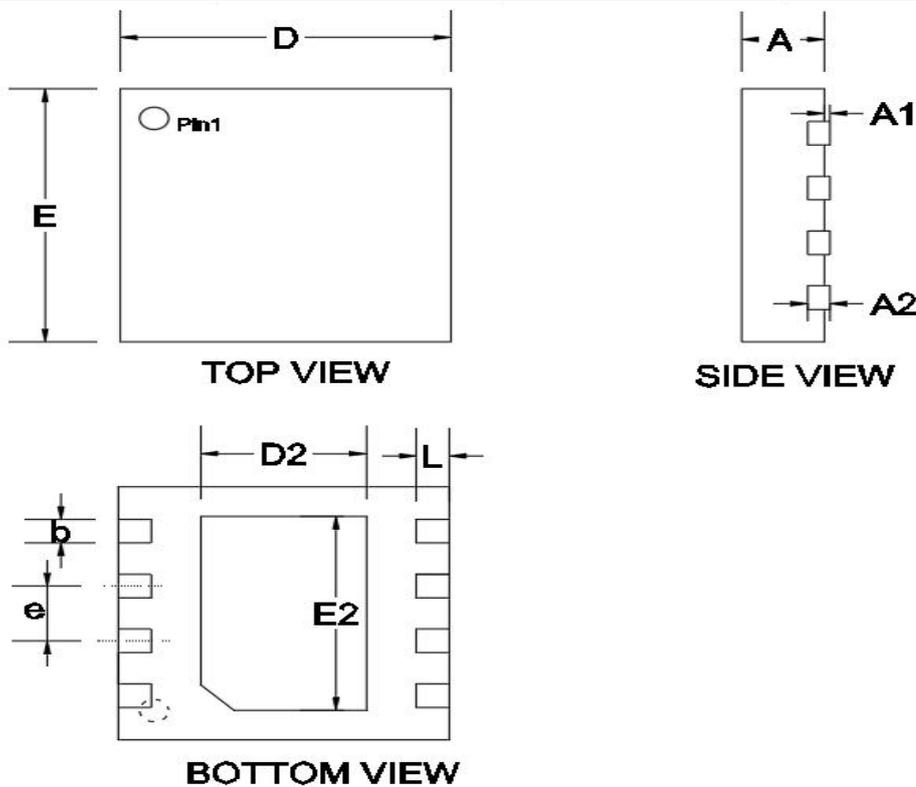
Picture 4. Fall propagation delay (VDD=5V,



## 8. Device dimensions

### 8.1 DFN3x3 Dimensions

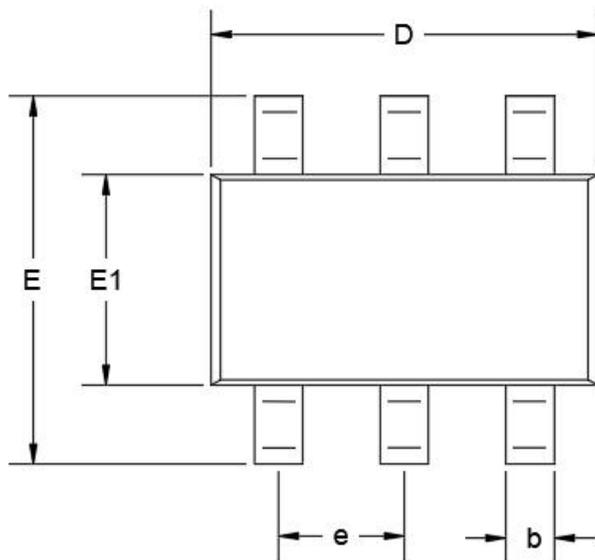
尺寸对照表(单位: mm)			
	Min.	Nom.	Max.
A	0.70	0.75	0.80
A1	-	-	0.05
A2	0.203(REF)		
b	0.23	0.28	0.33
D	2.90	3.00	3.10
D2	1.40	1.50	1
E	2.90	3.00	3.10
E2	2.20	2.30	2.40
e	0.65(TYP)		
L	0.25	0.30	0.35



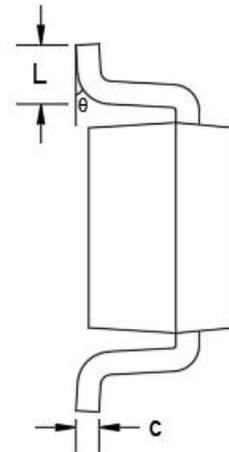
DFN3x3

## 8.2 SOT23-6 Dimensions

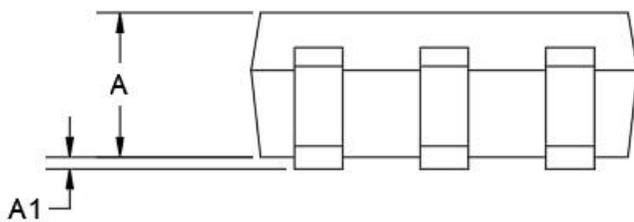
尺寸对照表(单位: mm)			
	Min.	Nom.	Max.
A	1.05	1.10	1.15
A1	0.03	0.09	0.15
b	0.28	0.37	0.45
C	0.12	0.18	0.23
D	2.82	2.92	3.02
E	2.60	2.80	3
E1	1.50	1.60	1.70
e	0.95(BSC)		
L	0.35	0.45	0.55
$\theta$	0°	4°	8°



TOP VIEW



SIDE VIEW



SIDE VIEW

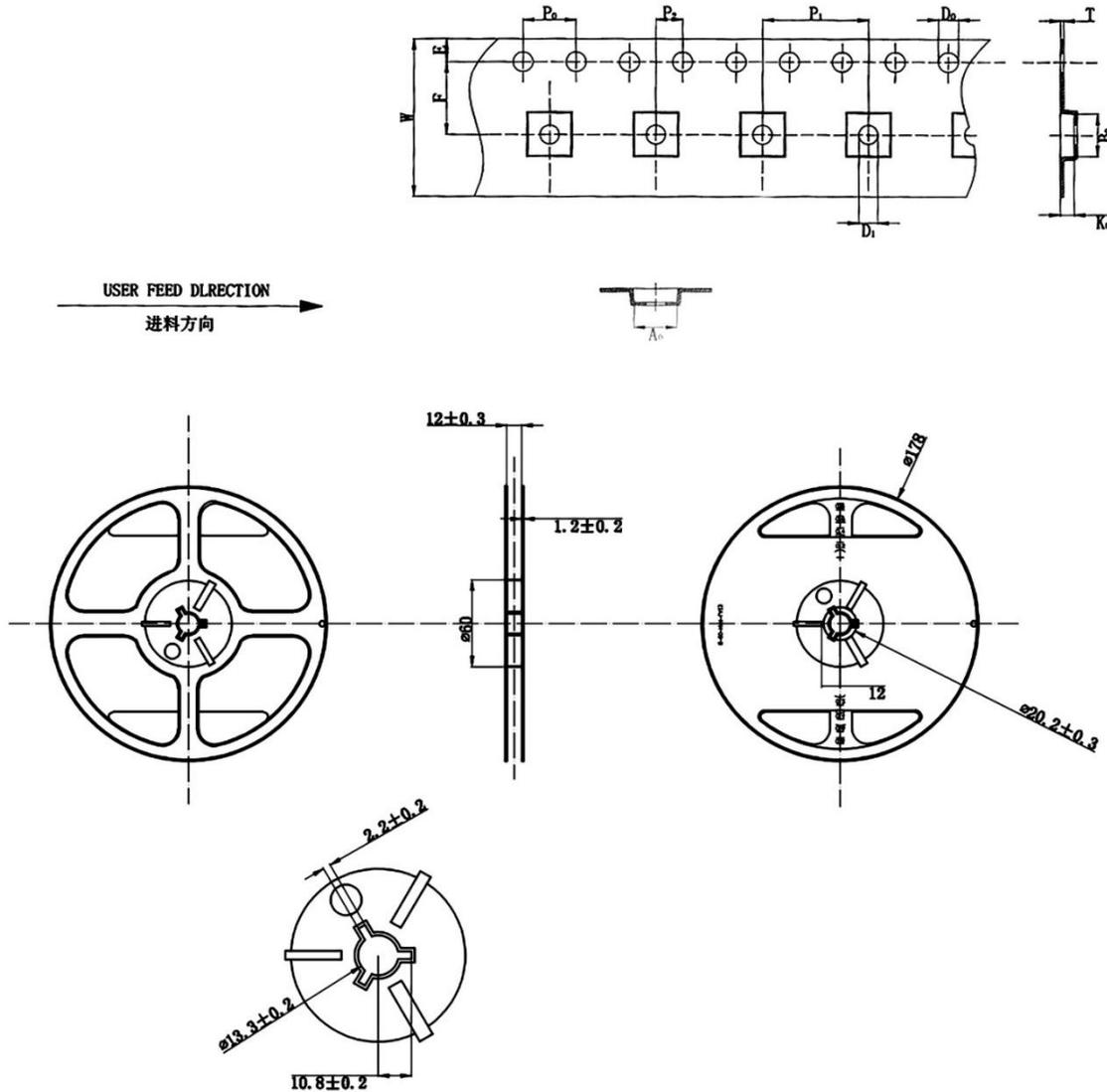
SOT23-6



## 9. Product packaging

### 9.1 DFN3x3

ITEM	W	A0	B0	K0	E	F	D1	D0	P0	P1	P2	T
MIN	11.90	3.13	3.13	0.95	1.65	5.45	-	-	3.90	7.90	1.95	0.18
NOM	12.00	3.23	3.23	1.05	1.75	5.50	1.50	1.50	4.00	8.00	2.00	0.23
MAX	12.30	3.33	3.33	1.15	1.85	5.55	1.60	1.60	4.10	8.10	2.05	0.28



9.2 SOT23-6

ITEM	W	A <sub>0</sub>	B <sub>0</sub>	K <sub>0</sub>	E	F	D <sub>1</sub>	D <sub>0</sub>	P <sub>0</sub>	P <sub>1</sub>	P <sub>2</sub>	t
MIN	7.80	3.15	3.25	1.28	1.65	3.45	-		3.90	3.90	1.95	0.20
NOM	8.00	3.25	3.30	1.38	1.75	3.50	1.00	1.50	4.00	4.00	2.00	0.25
MAX	8.20	3.35	3.40	1.48	1.85	3.55	1.10	1.60	4.10	4.10	2.05	0.30

